



1. General Description

The eKF5250 provides a high-performance interface to bridge USB and NAND Flash compliance device which can be used to implement of flash memory storage device with USB interface. It contains a 8-bit RISC processor to greatly reduce firmware development work.

The eKF5250 has a phase Lock Loop(PLL) embedded. The PLL provided all clocks needed in this Controller. It needs an externally provided clock operating in 2 Mhz.

The eKF5250 can control up to 4 pieces of NAND Flash memory. The flash capacity can be 16M bytes up to 256M bytes. And these chips can be any combination. It has been optimized to support Toshiba and Samsung flash memory designs. The controller has write-protected ability to prevent writing data to flash. For read/write operation, the controller can achieve 1000KB /800KB throughput.

This controller can operate in Win XP, Win2000, Windows ME without any driver installation.

2. Features

- USB Specification v1.1 Compliant
- USB Mass Storage Class v1.0 Compliant
- Support 12 Mbits/s Full Speed Serial Data Transmission
- Support USB Mass Storage Class Bulk-Only Spec.
- USB bus-powered capability
- Build in PLL used to generate clock for USB. And MCU.
- Total 3 Endpoints. Endpoint 0 is the default control endpoint. Endpoint 1 is the Bulk-in endpoint. Endpoint 2 is the Bulk-out endpoint.
- 4K x 13 on chip ROM(Program).
- Support wear leveling
- Support write-protected ability.
- Higher reliability : ECC on the fly
- Support ping-pong buffer(Two 536x8 bits) for data transfer to/from NAND Flash
- Support 4 pieces of NAND Flash.memory
- 8 Level stack for subroutine nesting.
- 1 LED sink pin with internal serial resistor.
- One 8 bits general purpose timer.
- Watchdog Timer with its own on-chip RC oscillator



Preliminary

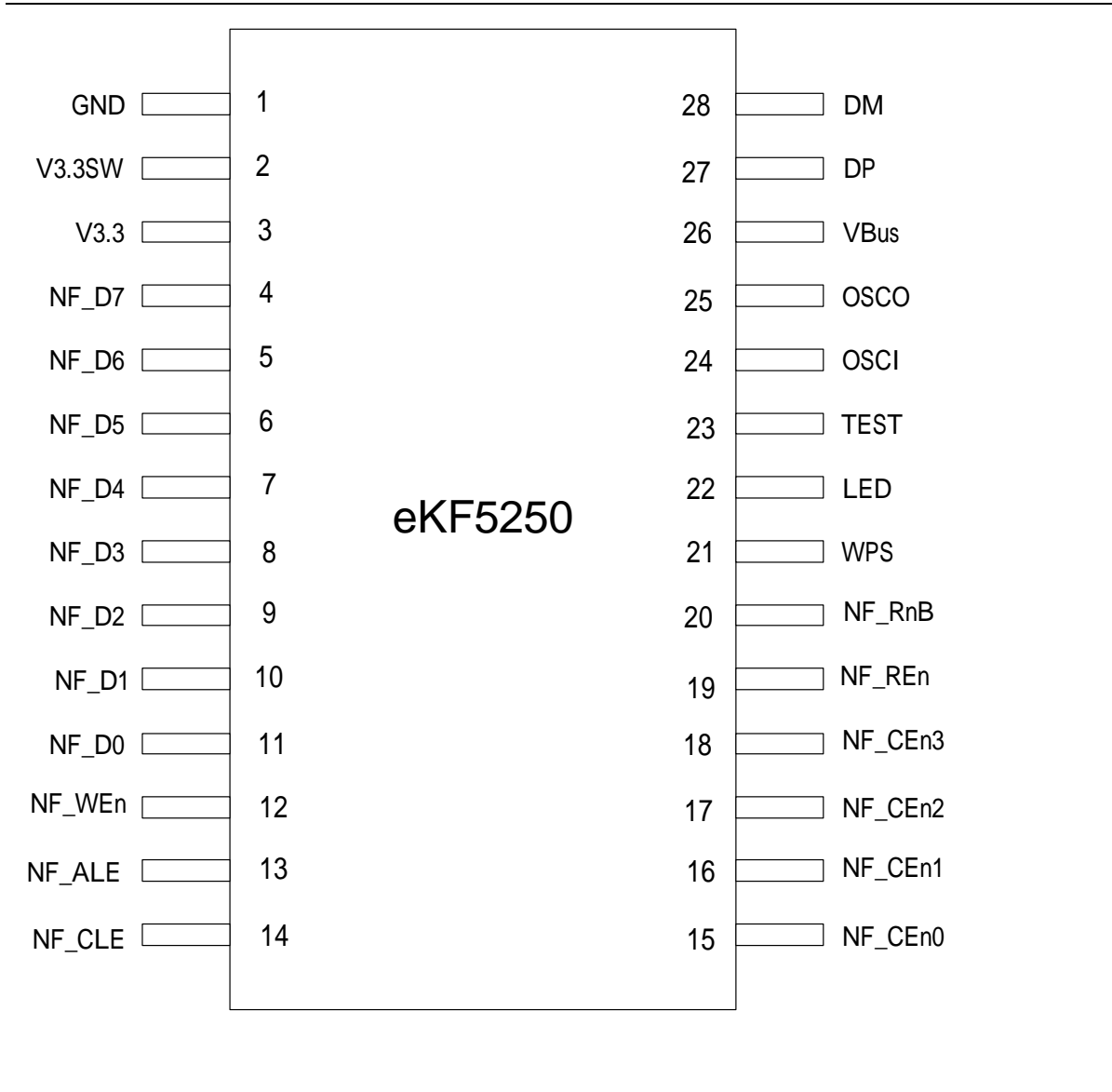
- Supports saving power mode(SLEEP MODE)
- MCU run at 16MHz.
- Performance : Read(1000K Bytes/s), Write(800K Bytes/s) Max.
- Package : SSOP28

3. Applications

- NAND Flash Controller
 - Smart Media Controller
-



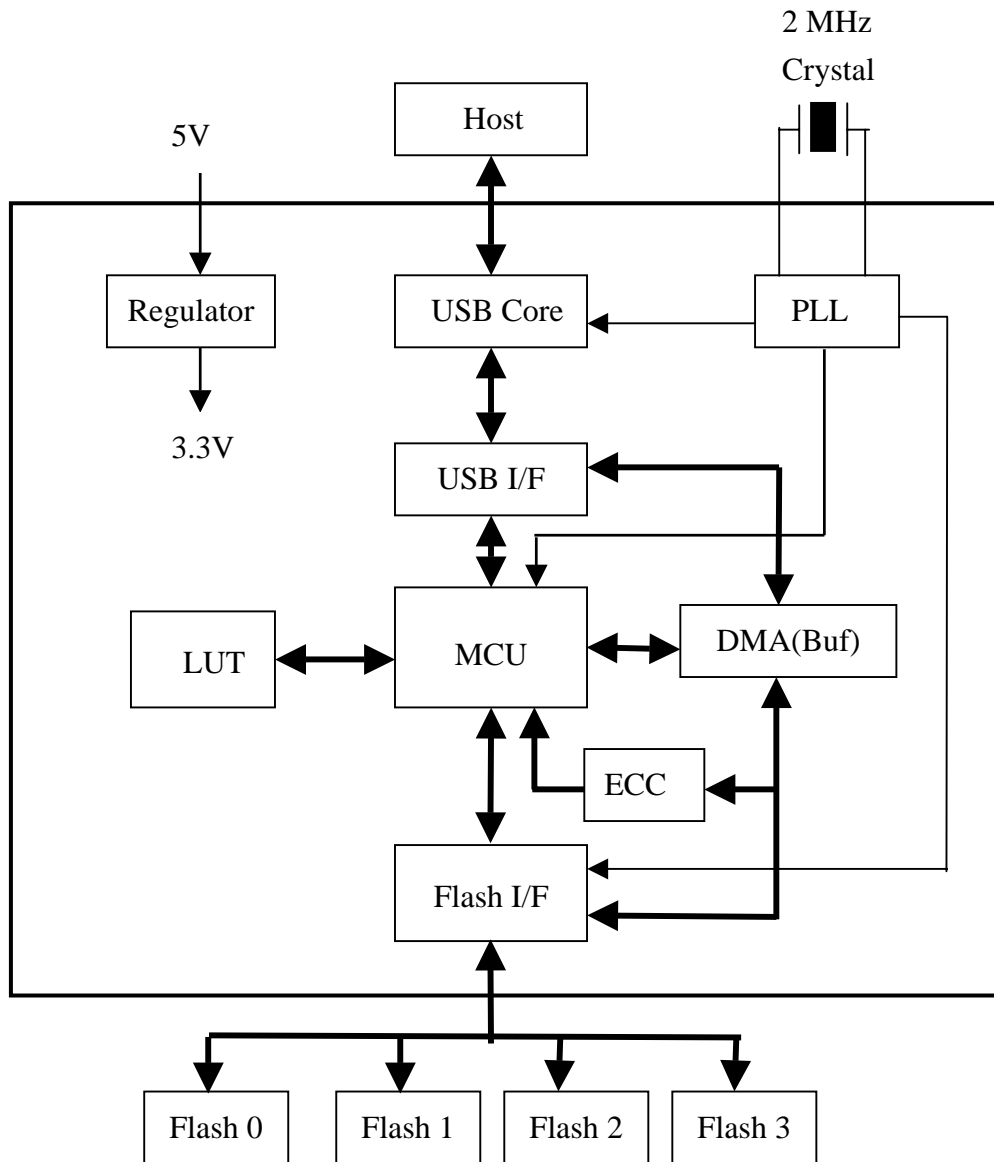
4. Pin Configuration



**5. Pin Description**

| Name | I/O type | Description | Note |
|-----------------------------|----------|--|-------|
| Power and ground pin | | | |
| Vbus | - | Power supply | |
| GND | - | Ground | |
| V3.3 | O | 3.3V output voltage | |
| USB analog signal | | | |
| DP | I/O | USB plus data line interface | |
| DM | I/O | USB minus data line interface | |
| V3.3SW | O | 1.5Kohm pull high terminal | |
| NAND Flash interface signal | | | |
| NF_CEn0 | I/O | Chip enable for NAND Flash 0 | I/O7 |
| NF_CEn1 | I/O | Chip enable for NAND Flash 1 | I/O7 |
| NF_CEn2 | I/O | Chip enable for NAND Flash 2 | I/O7 |
| NF_CEn3 | I/O | Chip enable for NAND Flash 3 | I/O7 |
| NF_D7~0 | I/O | Data input/output for NAND Flash | I/O7 |
| NF_WEn | O | Write enable for NAND Flash | O9 |
| NF_REn | O | Read enable for NAND Flash | O9 |
| NF_ALE | O | Address latch enable for NAND Flash | O8 |
| NF_CLE | O | Command latch enable for NAND Flash | O8 |
| NF_RnB | I | NAND Flash Ready or Busy | I-U5 |
| MISC | | | |
| OSCI | I | Crystal input terminal or external clock input | |
| OSCO | O | Output terminal for crystal osc. or external clock | |
| LED | O | LED sink pin | O10 |
| WPS | I | Write protect switch | I-U50 |
| TEST | I | TEST Pin | I-L10 |

6. Block Diagram





7. Function Description

To help the system manufactures to build high quality, low cost USB storage systems, several special feature which described as below are implement. The eKF5250 support the down-grade/untested NAND Flash. By testing the target NAND flash, if bad block is found, the controller will mark this bad block and will not use this block hereafter. Therefore, the integrated test software including format program will be support.

To reduce cost and increase performance and reliability, the eKF5250 build-in SRAM (Look-Up-Table) to support logical-to physical address translation. The eKF5250 also build-in ECC function, the real time ECC correction keeps the data integrity while still maintains the high data transfer rate.

Regarding flash, erase/program operation by the high voltage can cause oxide degradation and failure if it is repeated without limit. The wear-level algorithm is implement in the firmware. Update data of a block into a physically different with new link list also help alleviates repetitive cycling.

The 5 volts to 3.3 volts regulator is build-in, so no regulator needed externally. The BOM will be reduced.

No driver needed under Microsoft Windows ME/2000/XP, driver will be supported for Windows 98.

8. Absolute Maximum Ratings

| Symbol | Min | Max | Unit |
|------------------------|------|-----|------|
| Temperature under bias | 0 | 70 | °C |
| Storage temperature | -65 | 150 | °C |
| Input voltage | -0.5 | 6.0 | V |
| Output voltage | -0.5 | 6.0 | V |

**9. DC Electrical Characteristic**($T = 0^{\circ}\text{C} \sim 70^{\circ}\text{C}$, $V_D=3.3\text{V}$, $\text{GND}=0\text{V}$)

9.1 I/O7

| Symbol | Parameter | Condition | Min | Typ | Max | Unit |
|--------|---------------------|------------------------------|-----|-----|-----|------|
| VIH1 | Input High Voltage | | 2.0 | | | V |
| VIL1 | Input Low Voltage | | | | 0.8 | V |
| VOH1 | Output High Voltage | $\text{IOH} = -7.0\text{mA}$ | 2.4 | | | V |
| VOL1 | Output Low Voltage | $\text{IOL} = 7.0\text{mA}$ | | | 0.4 | V |

9.2 O8

| Symbol | Parameter | Condition | Min | Typ | Max | Unit |
|--------|---------------------|------------------------------|-----|-----|-----|------|
| VOH2 | Output High Voltage | $\text{IOH} = -8.0\text{mA}$ | 2.4 | | | V |
| VOL2 | Output Low Voltage | $\text{IOL} = 8.0\text{mA}$ | | | 0.4 | V |

9.3 O9

| Symbol | Parameter | Condition | Min | Typ | Max | Unit |
|--------|---------------------|------------------------------|-----|-----|-----|------|
| VOH3 | Output High Voltage | $\text{IOH} = -9.0\text{mA}$ | 2.4 | | | V |
| VOL3 | Output Low Voltage | $\text{IOL} = 9.0\text{mA}$ | | | 0.4 | V |

9.4 O10

| Symbol | Parameter | Condition | Min | Typ | Max | Unit |
|--------|---------------------|------------------------------|------|-----|------|------|
| VOH4 | Output High Voltage | $\text{IOH} = -8.0\text{mA}$ | 2.4 | | | V |
| VOL4 | Output Low Voltage | $\text{IOL} = 10.0\text{mA}$ | -10% | 1.3 | +10% | V |

9.5 I-U5

| Symbol | Parameter | Condition | Min | Typ | Max | Unit |
|-----------------|--------------------|-----------|------|-----|------|------------|
| VIH5 | Input High Voltage | | 2.0 | | | V |
| VIL5 | Input Low Voltage | | | | 0.8 | V |
| R _{us} | Pull-high resistor | | -20% | 5 | +20% | K Ω |

**9.6 I-U50**

| Symbol | Parameter | Condition | Min | Typ | Max | Unit |
|---------------|--------------------|------------------|------------|------------|------------|-------------|
| VIH6 | Input High Voltage | | 2.0 | | | V |
| VIL6 | Input Low Voltage | | | | 0.8 | V |
| Ru6 | Pull-high resistor | | -20% | 50 | +20% | K Ω |

9.7 I-L10

| Symbol | Parameter | Condition | Min | Typ | Max | Unit |
|---------------|--------------------|------------------|------------|------------|------------|-------------|
| VIH7 | Input High Voltage | | 2.0 | | | V |
| VIL7 | Input Low Voltage | | | | 0.8 | V |
| Ru7 | Pull-low resistor | | -20% | 10 | +20% | K Ω |

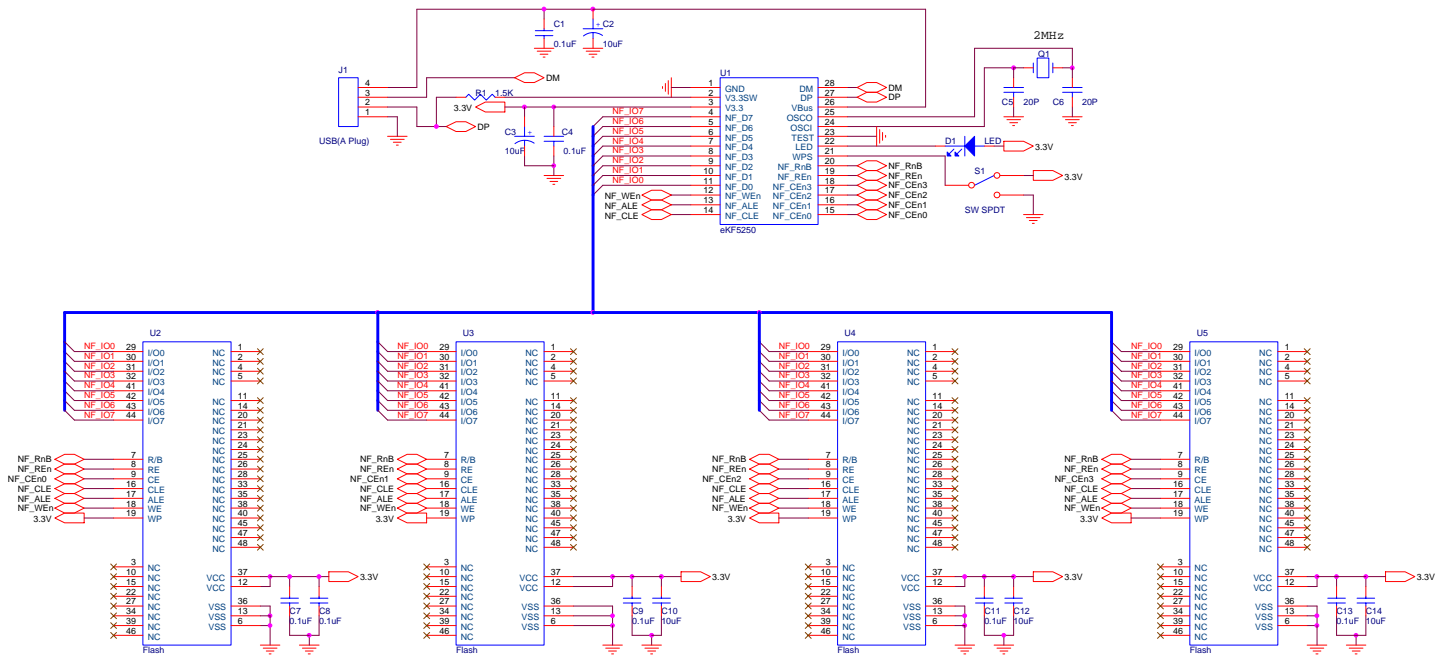
9.8 MISC

| Symbol | Parameter | Condition | Min | Typ | Max | Unit |
|---------------|--------------------------|------------------|------------|------------|------------|-------------|
| Vbus | USB bus power | | 4.4 | | 5.25 | V |
| IIL | Input Leakage Current | VIN = VD | | | ± 1 | μ A |
| VIHX | Clock Input High Voltage | OSCI | 2.5 | | | V |
| VILX | Clock Input Low Voltage | OSCI | | | 1.0 | V |
| ISB | Power down current | | | | 450 | μ A |
| ICC | Operating supply current | | | | 33 | mA |



Preliminary

10. Application Circuit



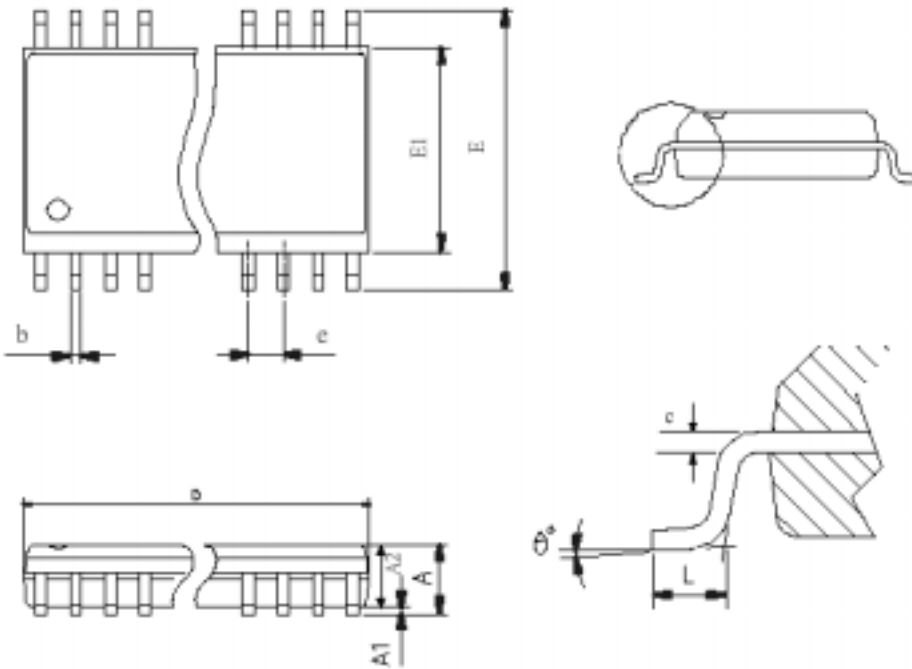


eKF5250

USB full speed NAND flash controller

Preliminary

11. Package



| Symbal | Min | Normal | Max |
|----------|------------|--------|--------|
| A | | | 2.130 |
| A1 | 0.050 | | 0.250 |
| A2 | 1.620 | 1.750 | 1.880 |
| b | 0.220 | | 0.380 |
| c | 0.090 | | 0.200 |
| E | 7.400 | 7.800 | 8.200 |
| E1 | 5.000 | 5.300 | 5.600 |
| D | 9.900 | 10.200 | 10.500 |
| L | 0.630 | 0.900 | 1.030 |
| c | 0.650(TYP) | | |
| θ | 0 | 4 | 8 |

Unit : mm



eKF5250

USB full speed NAND flash controller

Preliminary

© 2002 ELAN Microelectronics Corporation

All Rights Reserved

Printed in Taiwan, ROC, 05/2002

The contents of this specification are subject to change without notice. ELAN Microelectronics assumes no responsibility for errors that may appear in this specification. ELAN Microelectronics makes no commitment to update, or to keep current, the information contained in this specification. The products described herein are not intended for use in life support appliances, devices, or systems. Use of ELAN Microelectronics products in such applications are not supported and is prohibited.

NO PART OF THIS SPECIFICATION MAY BE REPRODUCED OR TRANSMITTED IN ANY FORM OR BY ANY MEANS WITHOUT THE EXPRESS WRITTEN PERMISSION OF ELAN MICROELECTRONICS.

ELAN MICROELECTRONICS CORPORATION

Headquarters:

No. 12, Innovation Road 1,
Science-based Industrial Park,
Hsinchu, Taiwan, R.O.C.
Tel: +886 3 5639977
Fax: +886 3 5639966
<http://www.emc.com.tw>

Hong Kong Office:

Rm. 1005B, 10/F Empire Centre
68 Mody Road, Tsimshatsui
Kowloon, HONG KONG
Tel: +852 2838-8715
Fax: +852 2838-0497